# MOSFET – Power, Single P-Channel, SOT-23, 2.4 x 2.9 x 1.0 mm

## -20 V, -5.5 A

#### **Features**

- Low R<sub>DS(on)</sub> Solution in 2.4 mm x 2.9 mm Package
- ESD Diode-Protected Gate
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

#### **Applications**

- High Side Load Switch
- Battery Switch
- Optimized for Power Management Applications for Portable Products, such as Smart Phones, Media Tablets, PMP, DSC, GPS, and Others

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise stated)

Paramet	Symbol	Value	Unit			
Drain-to-Source Voltage	V <sub>DSS</sub>	-20	V			
Gate-to-Source Voltage			V <sub>GS</sub>	±8	V	
Drain Current (Note 1)	` ,				Α	
Drain Current (Note 1)	State	T <sub>A</sub> = 85°C		-2.2		
	t ≤ 5 s	T <sub>A</sub> = 25°C		-5.5		
Power Dissipation (Note 1)	Steady State	T <sub>A</sub> = 25°C	P <sub>D</sub>	0.48	W	
	t≤5s			1.58		
Pulsed Drain Current	I <sub>DM</sub>	-9.1	Α			
Operating Junction and Sto	T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	°C			
ESD HBM, JESD22-A114	V <sub>ESD</sub>	2000	V			
Source Current (Body Diod	Is	-0.48	Α			
Lead Temperature for Soldering Purposes (1/8 in from case for 10 s)			TL	260	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	260	°C/W
Junction-to-Ambient – $t \le 5$ s (Note 1)	$R_{\theta JA}$	79	

- 1. Surface-mounted on FR4 board using 1 in sq. pad size (Cu area = 1.127 in sq. [2 oz] including traces).
- 2. Pulse Test: pulse width  $\leq 300$  ms, duty cycle  $\leq 2\%$ .

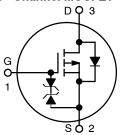


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V <sub>(BR)DSS</sub>	V <sub>(BR)DSS</sub> R <sub>DS(on)</sub> Max	
-20 V	38 mΩ @ -4.5 V	
	50 mΩ @ -2.5 V	–5.5 A
	73 mΩ @ –1.8 V	

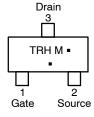
#### P-Channel MOSFET



# MARKING DIAGRAM & PIN ASSIGNMENT



SOT-23 CASE 318 STYLE 21



TRH = Specific Device Code

M = Date Code\*= Pb-Free Package

(Note: Microdot may be in either location)

\*Date Code orientation may vary depending upon manufacturing location.

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTR3A30PZT1G	SOT-23 (Pb-Free)	3000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

## **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS					-	•	
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		-20			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>	I <sub>D</sub> = -250 μA, ref	to 25°C		10.5		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 \text{ V},$ $V_{DS} = -20 \text{ V}$ $T_{J} = 25^{\circ}\text{C}$				-1	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS}$	= ±5 V			±10	μΑ
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D = -250 \mu A$		-0.4	-0.65	-1.0	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				10.5		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = -4.5 V	I <sub>D</sub> = -3 A		31	38	mΩ
		V <sub>GS</sub> = −2.5 V	I <sub>D</sub> = -2.5 A		36	50	1
		V <sub>GS</sub> = -1.8 V	I <sub>D</sub> = -1.5 A		51	73	1
Forward Transconductance	9FS	$V_{DS} = -5 \text{ V}, I_{D}$	= -3 A		30		S
CHARGES AND CAPACITANCES							
Input Capacitance	C <sub>iss</sub>				1651		pF
Output Capacitance	C <sub>oss</sub>	V <sub>GS</sub> = 0 V, f = 1.0 MHz, V <sub>DS</sub> = -15 V			148		1
Reverse Transfer Capacitance	C <sub>rss</sub>				129		1
Total Gate Charge	Q <sub>G(TOT)</sub>				17.6		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	\/ 45\/\/	15 V I 2 A		0.7		
Gate-to-Source Charge	Q <sub>GS</sub>	$V_{GS} = -4.5 \text{ V}, V_{DS} = -15 \text{ V}, I_D = -3 \text{ A}$			2.4		
Gate-to-Drain Charge	$Q_{GD}$				4.9		
SWITCHING CHARACTERISTICS (Note	e 4)						
Turn-On Delay Time	t <sub>d(on)</sub>				100		ns
Rise Time	t <sub>r</sub>	$V_{GS}$ = -4.5 V, $V_{DS}$ = -15 V, $I_{D}$ = -3 A, $R_{G}$ = 6.0 $\Omega$			208		
Turn-Off Delay Time	t <sub>d(off)</sub>				1043		
Fall Time	t <sub>f</sub>				552		
DRAIN-SOURCE DIODE CHARACTER	ISTICS						
Forward Diode Voltage	$V_{SD}$	V <sub>GS</sub> = 0 V,	$T_J = 25^{\circ}C$		0.65	1.0	V
		$I_{S} = -0.4 \text{ A}$	T <sub>J</sub> = 125°C		0.47		]

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Pulse Test: pulse width ≤ 300 ms, duty cycle ≤ 2%.

4. Switching characteristics are independent of operating junction temperatures.

#### TYPICAL CHARACTERISTICS

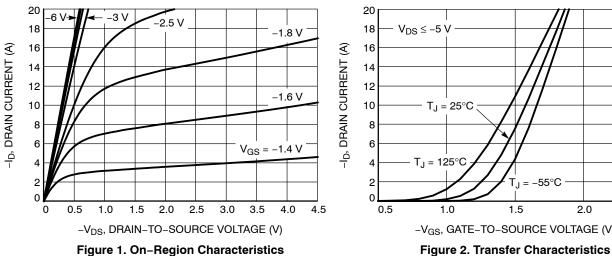
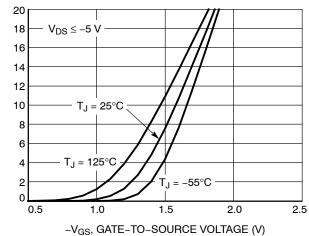


Figure 1. On-Region Characteristics



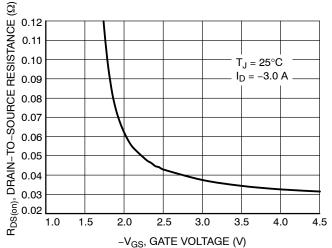


Figure 3. On-Resistance vs. Gate-to-Source Voltage

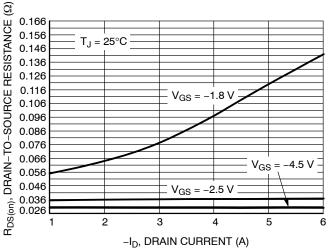


Figure 4. On-Resistance vs. Drain Current and **Gate Voltage** 

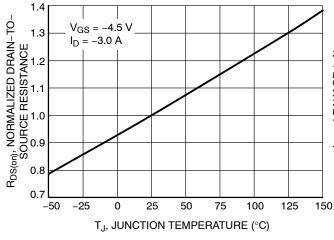


Figure 5. On-Resistance Variation with **Temperature** 

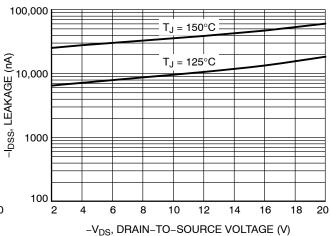


Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### TYPICAL CHARACTERISTICS

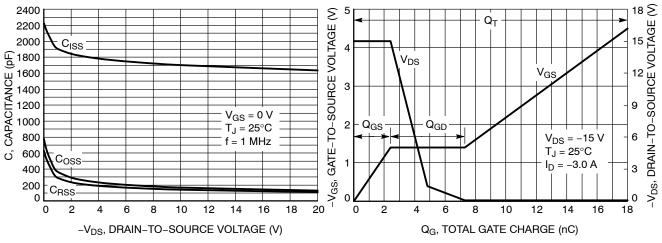
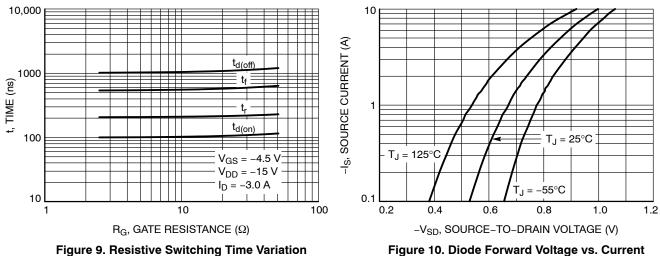


Figure 7. Capacitance Variation

Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge



 $I_D = -250 \,\mu A$ 

125

Figure 9. Resistive Switching Time Variation vs. Gate Resistance

0.9

0.7

0.6

0.5

0.4

0.3

0.2

-50 -25

-V<sub>GS(th)</sub> (V)

100  $0 \le V_{GS} \le -8 \text{ V}$ Single Pulse  $T_C = 25^{\circ}C$ -ID, DRAIN CURRENT (A) 10 100 μs 1 ms 10 ms 0.1 R<sub>DS(on)</sub> Limit Thermal Limit DC Package Limit 0.01 150 0.1

T<sub>J</sub>, JUNCTION TEMPERATURE (°C) Figure 11. Threshold Voltage

75

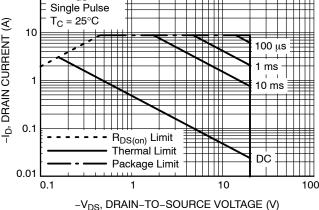


Figure 12. Maximum Rated Forward Biased Safe Operating Area

## **TYPICAL CHARACTERISTICS**

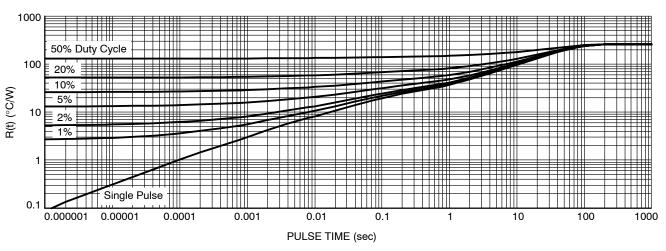
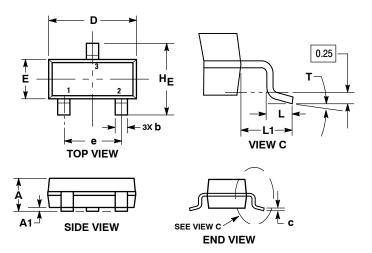


Figure 13. FET Thermal Response

#### PACKAGE DIMENSIONS

#### SOT-23 (TO-236) CASE 318-08 **ISSUE AR**



- NOTES:

  1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.

  2. CONTROLLING DIMENSION: MILLIMETERS.

  3. MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH.
  MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF
- THE BASE MATERIAL.
  DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH,
  PROTRUSIONS, OR GATE BURRS.

	MILLIMETERS			INCHES		
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	0.89	1.00	1.11	0.035	0.039	0.044
A1	0.01	0.06	0.10	0.000	0.002	0.004
b	0.37	0.44	0.50	0.015	0.017	0.020
С	0.08	0.14	0.20	0.003	0.006	0.008
D	2.80	2.90	3.04	0.110	0.114	0.120
E	1.20	1.30	1.40	0.047	0.051	0.055
е	1.78	1.90	2.04	0.070	0.075	0.080
L	0.30	0.43	0.55	0.012	0.017	0.022
L1	0.35	0.54	0.69	0.014	0.021	0.027
HE	2.10	2.40	2.64	0.083	0.094	0.104
Т	0°		10°	0°		10°

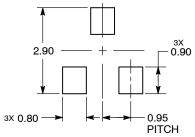
#### STYLE 21:

PIN 1. GATE 2. SOUR

SOURCE

DRAIN

#### **RECOMMENDED** SOLDERING FOOTPRINT\*



**DIMENSIONS: MILLIMETERS** 

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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